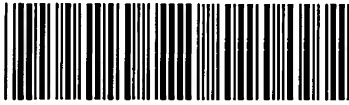


Search Notes

Application/Control No.

10/573,459

Examiner

Hae M. Hyeon

Applicant(s)/Patent under
Reexamination

JAMES, JASON L.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	490	1/07	hmb
439	540.1	↓	↓
379	326	↓	↓
379	320	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR